

Notice of References Cited

Application/Control No.

10/527,699

Applicant(s)/Patent Under
Reexamination
KOBAYASHI ET AL.

Examiner

Rip A. Lee

Art Unit

1713

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,045,436	09-1991	Tieke et al.	430/315
*	C	US-6,743,873	06-2004	Kirk et al.	526/204
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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